



# **INS6310A** —1:10 Ultra-Low Additive Jitter **Differential Clock Buffer**

## **FEATURES**

- Two banks with 5 differential outputs each
  - LVPECL, LVDS, HCSL or Hi-Z (selectable per bank)  $\geq$
  - $\triangleright$ LVPECL additive jitter with clock source at 122.88MHz
    - $\triangleright$ 40 fs RMS (10KHz to 1MHz)
    - 80 fs RMS (12KHz to 20MHz)  $\geq$
- 3:1 Input Multiplexer
  - Two universal inputs operate up to 2.5GHz and accept LVPECL, LVDS, CML, SSTL, HSTL, HCSL or single-ended clocks
  - One crystal input accepts 10 to 40MHz crystal or single-ended clock  $\triangleright$
- High PSRR: -65/-76dBc (LVPECL/LVDS) at 156.25MHz •
- LVCMOS output with synchronous enable input
- Pin-Controlled configuration •
- $V_{DD}$  core supply:  $3.3V \pm 5\%$
- 3 independent V<sub>DDO</sub> output supplies:  $3.3V/2.5V \pm 5\%$
- Industrial temperature range: -40°C to +85°C •
- Package: QFN48(7.0mm\*7.0mm\*0.75mm)

### APPLICATIONS

- High speed Clock distribution and level translation
- Wireless BBU, RRU and Wired Communication
- Servers, Computing, PCI Express (PCIe)
- Switches, Routers, Line Cards, Timing Cards

## **GENERAL DESCRIPTIONS**

The INS6310A is a high performance, versatility 10-output differential fanout buffer intended for high-frequency, lowjitter clock/data distribution and level translation. The input clock can be selected from two universal inputs or one crystal input. The selected input clock is distributed to two banks of 5 differential outputs and one LVCMOS output. Both differential output banks can be independently configured as LVPECL, LVDS, or HCSL drivers, or disabled. The LVCMOS output has a synchronous enable input for runt-pulse-free operation when enabled or disabled. The INS6310A operates from a 3.3V core supply and 3 independent 3.3V/2.5V output supplies.

TEL:0086-0769-88010888 https://www.dptel.com/ Songshan Lake, Dongguan, Guangdong



N56310

**CLK1** CLK1 6

EPAD

QA0

nQA QA1 3

nQA1 4

DDO/ 5

QA2

DDO4

OA3 9

nQA4 12

nQA3 10

2

6

7 nQA2

8

11 OA4

QB0

QB2

VDDOB

nQB3 27

36

35 nOB0

34 QB1

33 nQB1

32 /DDOB

31

30 nQB2

29

28 OB3

26 QB4

25 nQB4

GND





# **Table of Amendment**

Version	Revised Content	Draft	Revised Date	
V1.0	Chinese Version		2021.11.29	
V1.1	English Version. Change V <sub>DDOX</sub> maximum Voltage from 3.465V to 3.45V.		2022.02.08	
V1.2	Error Correction: nQB* QB* pin swap in Pinouts diagram on Page 1 and Page 5		2022.06.23	
	•		Ś	
		X		
		533		
	Eor.			

TEL:0086-0769-88010888

8 https://www.dptel.com/

/ Songshan Lake, Dongguan, Guangdong





# Table of Contents

1	GENERAL DESCRIPTION	4
2	FUNCTIONAL BLOCK DIAGRAM	4
3	PINOUTS	5
4	ELECTRICAL CHARACTERISTICS	6
5	FUNCTION DESCRIPTION	14
	ENVIRONMENT	
7	PACKAGE OUTLINE	21

Version: <u>1.2</u>

TEL:0086-0769-88010888 https://www.dptel.com/

DAPU Confidential

om/ Songshan Lake, Dongguan, Guangdong

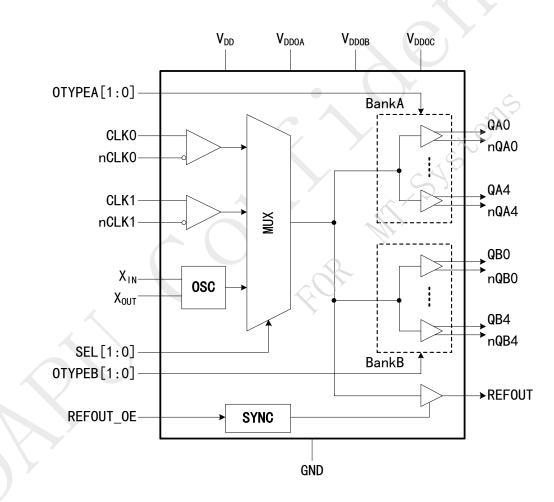
Page: 3 / 21

# 1 GENERAL DESCRIPTION

The INS6310A is a 2.5-GHz, 10-output differential fanout buffer intended for high-frequency, low-jitter clock/data distribution and level translation. The input clock can be selected from two universal inputs or one crystal input. The selected input clock is distributed to two banks of 5 differential outputs and one LVCMOS output. Both differential output banks can be independently configured as LVPECL, LVDS, or HCSL drivers, or disabled. The LVCMOS output has a synchronous enable input for runt-pulse-free operation when enabled or disabled. The INS6310A operates from a 3.3V core supply and 3 independent 3.3V/2.5V output supplies.

The INS6310A provides high performance, versatility, and power efficiency, making it ideal for replacing fixed-output buffer devices while increasing timing margin in the system.

The INS6310A does not have power supply sequencing requirements between the core and output supply domains.



# 2 FUNCTIONAL BLOCK DIAGRAM

Figure 1. Block Diagram

TEL:0086-0769-88010888

https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong

# **INS6310A**



## **3 PINOUTS**

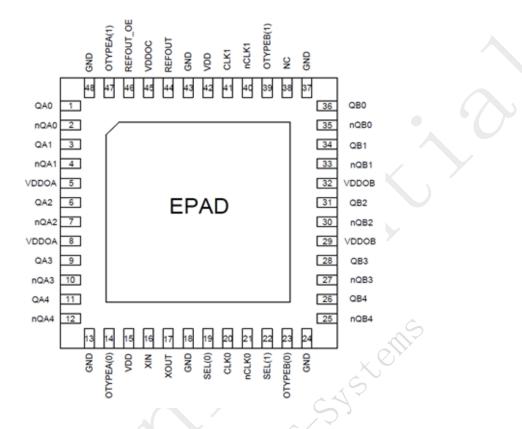


Figure 2. Pinouts Diagram

Table 1.	Pin	Defir	ition
----------	-----	-------	-------

PIN No.	PIN Name	TYPE	DESCRIPTIONS						
1,2	QA0,nQA0	OUT	Bank A Differential clock output 0						
3,4	QA1,nQA1	OUT	Bank A Differential clock output 1						
5,8	V <sub>DDOA</sub>	PWR	Power supply for Bank A output buffers. V <sub>DDOA</sub> can operate from 3.3V or 2.5V. The V <sub>DDOA</sub> pins are internally tied together. Bypass with a 0.1uF low-ESR capacitor placed very close to each V <sub>DDO</sub> pin.						
6,7	QA2,nQA2	OUT	Bank A Differential clock output 2						
9,10	QA3,nQA3	OUT	Bank A Differential clock output 3						
11,12	QA4,nQA4	OUT	Bank A Differential clock output 4						
13, 18, 24, 37, 43, 48	GND	GND	Ground						
14,47	OTYPEA[0] OTYPEA[1]	IN	Bank A Outputs selection pins. Pull down internally.						
15,42	V <sub>DD</sub>	PWR	Power supply for core and input buffer blocks. The VDD supply operates from 3.3V. Bypass with a 0.1uF low-ESR capacitor placed very close to each VDD pin.						

TEL:0086-0769-88010888

https://www.dptel.com/

el.com/ Songsha





PIN No.	PIN Name	TYPE	DESCRIPTIONS		
16	X <sub>IN</sub>	IN	Input for crystal. Can also be driven by a XO, TCXO, or other external single-ended clock.		
17	X <sub>OUT</sub>	OUT	Output for crystal. Leave $X_{OUT}$ floating if $X_{IN}$ is driven by a single- ended clock.		
19,22	SEL[0] SEL[1]	IN	Clock input selection pins. Pull down internally.		
20,21	CLK0,nCLK0	IN	Universal clock input 0 (differential/single-ended).		
23,39	OTYPEB[0] OTYPEB[1]	IN	Bank A Outputs selection pins. Pull down internally.		
25,26	nQB4,QB4	OUT	Bank B Differential clock output 4		
27,28	nQB3,QB3	OUT	Bank B Differential clock output 3		
29,32	V <sub>DDOB</sub>	PWR	Power supply for Bank A output buffers. $V_{DDOA}$ can operate from 3.3V or 2.5V. The $V_{DDOA}$ pins are internally tied together. Bypass with a 0.1uF low-ESR capacitor placed very close to each $V_{DDO}$ pin.		
30,31	nQB2,QB2	OUT	Bank B Differential clock output 2		
33,34	nQB1,QB1	OUT	Bank B Differential clock output 1		
35,36	nQB0,QB0	OUT	Bank B Differential clock output 0		
38	NC	- ^	Not connected internally. Pin may be floated or grounded.		
40,41	nCLK1,CLK1	IN	Universal clock input 1 (differential/single-ended).		
44	REFOUT	OUT	LVCMOS reference output. Enable output by pulling REFOUT_OE pin high.		
45	V <sub>DDOC</sub>	PWR	Power supply for Bank A output buffers. $V_{DDOA}$ can operate from 3.3V or 2.5V. The $V_{DDOA}$ pins are internally tied together. Bypass with a 0.1uF low-ESR capacitor placed very close to each $V_{DDO}$ pin.		
46	REFOUT_OE	IN	REFOUT enable input. Enable signal is internally synchronized to select clock input. Pull down internally.		
	EPAD		Connect to the PCB ground plane for heat dissipation.		

# **4** ELECTRICAL CHARACTERISTICS

### Table 2. Absolute Maximum Ratings

Permanent device damage may occur if the absolute maximum ratings are exceeded. Functional operation should be restricted to the conditions as specified in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

	Parameters	Symbol	Value		Unit
•	TEL:0086-0769-88010888	https://www.dpt	el.com/ Songshan L	ake, Dongguan, G	iuangdong
		D / D1			







Power Supply Voltage	V <sub>DD</sub> V <sub>DDOA</sub> V <sub>DDOB</sub> V <sub>DDOC</sub>	-0.3~3.6	V	
Input Voltage	V <sub>IN</sub>	$-0.3 \sim V_{DD} + 0.3$	V	
Storage Temperature Range	T <sub>STG</sub>	-65~150	°C	
Junction Temperature	TJ	150	°C	
Thermal resistance from Junction to Ambient	$\theta_{\rm JA}$	28.5	°C/W	

$T_{a}h_{1a} 2$	Decommended	Donomotore
Table 5.	Recommended	Parameters

	Symbol	Value				
Parameters		Min.	Typ.	Max.	Unit	Notes
Core Supply Voltage	V <sub>DD</sub>	3.15	3.3	3.45	V	
Output	<b>V</b> (1)	3.135	3.3	3.45	N.	
Supply Voltage	V <sub>DDOX</sub> <sup>(1)</sup>	2.375	2.5	2.625	V	
	I		24	31	mA	All Outputs Disabled. Clock input 0 or 1 Selected.
	I <sub>VDD_CORE</sub>		23	30	mA	All Outputs Disabled. Xin Selected.
Core Supply	Ivdd_lvds		50	75	mA	Additive Core Supply Current, Per LVDS Bank Enabled
Current	I <sub>VDD_LVPECL</sub>		20	26	mA	Additive Core Supply Current, Per LVPECL Bank Enabled
	I <sub>VDD_HCSL</sub>		32	42	mA	Additive Core Supply Current, Per HSCL Bank Enabled
	I <sub>VDD_LVCMOS</sub>		4	5.2	mA	Additive Core Supply Current, Per LVCMOS Bank Enabled
	Ivddo_lvds		24	31	mA	Additive Out Supply Current, Per LVDS Bank Enabled
Output	Ivddo_lvpecl		230	299	mA	Additive Out Supply Current, Per LVPECL Bank Enabled
Supply Current	Ivddo_hcsl		72	94	mA	Additive Out Supply Current, Per HSCL Bank Enabled
	Ivddo_lvcmos		9	12	mA	Additive Out Supply Current, Per LVCMOS Bank Enabled
Ambient Temperature	T <sub>A</sub>	-40		85	°C	

\* (1) DDOX will represent  $_{DDOA/DDOB/DDOC}$  in general when no distinction is needed

 $Test \ Condition: -40^{\circ}C \le T_A \le 85^{\circ}C, 3.15V \le V_{DD} \le 3.45V, 2.375V \le V_{DDOX} \le 2.625 \ or \ 3.135V \le V_{DDOX} \le 3.45V, 3.15V \le 0.15V, 3.15V \le 0.15V, 3.15V, 3.15V \le 0.15V, 3.15V, 3.1$ 

Demons of our	C-makel		Value		<b>T</b> 1-+*4	Natar	
Parameters	Symbol	Min.	Тур.	Max.	Unit	Notes	
Control Signals (OTYPEA[0:1],OTYPEB[0:1],SEL[0:1],REFOUT_OE)							
High Level Input	I <sub>IH</sub>			50	uA		
 TEL:0086-0769-88010888 https://www.dptel.com/ Songshan Lake, Dongguan, Guangdong							





Current						
Low Level Input Current	I <sub>IL</sub>	-5	0.1	5	uA	
Input High Voltage	$V_{\mathrm{IH}}$	1.6		$V_{DD}$	V	
Input Low Voltage	V <sub>IL</sub>	0		0.4	V	

### Table 5. CLKx/nCLKx<sup>(2)</sup>

 $Test \ Condition: \ -40^{\circ}C \leq TA \leq 85^{\circ}C, 3.15V \leq V_{DD} \leq 3.45V, 2.375V \leq V_{DDOX} \leq 2.625 \ or \ 3.135V \leq V_{DDOX} \leq 3.45V, CLK \leq 10^{\circ}C < 10^{\circ}C <$ driven differentially, input slew rate  $\geq 3V/ns$ 

Demonsterne	Ch al		Value		TT \$4	Natar	
Parameters	Symbol	Min.	Тур.	Max.	Unit	Notes	
CLKx Single-Ended Inp	ut Clock Spec	ifications			Å	$\cap$	
Single-Ended Input High Voltage	V <sub>IH</sub>			V <sub>DD</sub>	V	CI Ku driven single	
Single-Ended Input Low Voltage	V <sub>IL</sub>	0			v	CLKx driven single- ended (AC or DC coupled), nCLKx AC	
Single-Ended Input Voltage Swing(P2P)	$V_{I\_SE} ~^{(3)}$	0.3	•	2	V	coupled to GND or externally biased within	
Single-Ended Input Common-Mode Voltage	$V_{CM}$ (4)	0.25	Ç	V <sub>DD</sub> -1.2	V	V <sub>CM</sub> range	
Differential Input Clock	Specification	s (CLKx	/nCLKx )		6		
Differential Input Voltage Swing	V <sub>ID</sub>	0.15		1.3	v		
Differential Input		0.25		V <sub>DD</sub> -0.9	v	V <sub>ID</sub> =800mV	
Common-Mode	$V_{CMD}$ (5)	0.25		V <sub>DD</sub> -1.1	V	V <sub>ID</sub> =350mV	
Voltage		0.25	- A	V <sub>DD</sub> -1.2	V	V <sub>ID</sub> =150mV	
Differential Input High Voltage	V <sub>IHD</sub>		Y	V <sub>DD</sub>	V		
Differential Input Low Voltage	V <sub>ILD</sub>	0			V		
			-65		dBc	F <sub>IN</sub> =1000MHz	
Mux Isolation,	100		-71		dBc	$F_{IN}$ =500MHz	
CLKin0 to CLKin	ISO <sub>IN</sub>		-82		dBc	F <sub>IN</sub> =200MHz	
7			-84		dBc	F <sub>IN</sub> =100MHz	
Input Frequency (CLK/	nCLK)						
Input Frequency Range	F <sub>IN</sub>	0		2500	MHz	Functional up to 2.5GHz Output frequency range and timing specified per output type (refer to LVPECL, LVDS, HCSL LVCMOS output	

Version: <u>1.2</u>

DAPU Confidential





Parameters	Symbol	Value		Unit	Notes	
						specifications)

\* (2) CLKx/nCLKx represent CLK0/nCLK0 和 CLK1/nCLK1

(3) For clock input frequency  $\geq$  100MHz, CLKx can be driven with single-ended (LVCMOS) input swing up to 3.3VPP.

For clock input frequency < 100MHz, the single-ended input swing should be limited to 2VPP max to prevent input

saturation (refer to Driving the Clock Inputs for interfacing 2.5V/3.3V LVCMOS clock input < 100MHz to CLKx).

(4) CLKx driven single-ended (AC or DC coupled), nCLKx AC coupled to GND or externally biased within V<sub>CM</sub> range

(5) AC coupled must be applied when  $V_{CM}$  of input signals exceed  $V_{CMD}$  Max..

Parameters	Growbal		Value	TI:+	Nuture	
Parameters	Symbol	Min. Typ.		Max.	Unit	Notes
Crystal Input				アイ		
Crystal Mode			Fundamental	Ň		Ċ
Crystal Frequency Input Range	f <sub>XIN</sub> /xout	10	$\sim$	40	MHz	202
Effective Series	ESR			200	Ω	10MHz <f<sub>XIN≤30 MHz</f<sub>
Resistance	ESK	125		S	Ω	30MHz <f<sub>XIN&lt;40 MHz</f<sub>
Input Capacitance	Cxo		4		pF	
Single-ended input				(h)		
External Clock Input Frequency	f <sub>XIN</sub>	DC	FOR	250	MHz	Single-Ended Input, Xout floating

Table 6. X<sub>IN</sub>/X<sub>OUT</sub> Characteristics

### Table 7. LVDS Outputs Characteristics

Test Condition:  $-40^{\circ}C \le T_A \le 85^{\circ}C$ ,  $3.15V \le V_{DD} \le 3.45V$ ,  $2.375V \le V_{DDOX} \le 2.625$  or  $3.135V \le V_{DDOX} \le 3.45$ , CLK driven differentially, input slew rate  $\geq 3V/ns$ 

Parameters	Symphol	Value			Unit	Notes	
Farameters	Symbol	Min.	Тур.	Max.	Umt	INOLES	
QAn/nQAn,QBn/nQB	n						
Maximum Output	F	1000	1600		MHz	Full V <sub>OD</sub> Swing, V <sub>OD</sub> >250mV, R <sub>L</sub> = $100\Omega$ differential	
Frequency	Fout-max	1500	2100		MHz	Reduced $V_{OD}$ Swing, $V_{OD}$ >200mV, $R_L = 100\Omega$ differential	
Output Voltage Swing	V <sub>OD</sub>	250	400	450	mV	$T_A = 25^{\circ}C, DC$	
Change in Magnitude of V <sub>OD</sub>	$\Delta V_{OD}$	-50		50	mV	Measurement, $R_L = 100\Omega$ differential	

TEL:0086-0769-88010888

https://www.dptel.com/





Parameters	Symbol		Value		Unit	Notes
for Complementary Output States						
Output Offset Voltage	VOFFSET	1.125	1.25	1.375	V	
Change in Magnitude of VOFFSET for Complementary Output States	$\Delta V_{OFFSET}$	-35		35	mV	
Output Duty Cycle	Duty Cycle	45	50	55	%	• • • • • •
Output Rise/Fall Time, 20% to 80%	t <sub>Rise</sub> /t <sub>Fall</sub>		175	300	ps	uniform transmission line up to 10 inches with $50\Omega$ characteristic impedance, $RL = 100\Omega$ differential, $C_L$ $\leq 5p$
Propagation Delay	t <sub>Delay</sub>	200	400	600	ps	$\begin{array}{l} RL = 100\Omega \text{ differential, } C_L \\ \leqslant 5 pF \end{array}$
Output Skew	t <sub>Skew</sub>		30	50	ps	Skew specified between any two CLKouts with the same buffer type. Load
Part-to-part Output Skew	t <sub>PDP</sub>		80	120	ps	conditions per output type are the same as propagation delay specifications.
			132		fs	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns 1MHz to 20MHz
			103		fs	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns 1MHz to 20MHz
Additive RMS Jitter	tı	$\bigcirc$	33	Q	fs	F <sub>IN</sub> =625MHz Slew Rate≥3V/ns 1MHz to 20MHz
~			138		fs	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns 10kHHz to 20MHz
			99		fs	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns 10kHHz to 20MHz
			-159.5		dBc/Hz	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns
Noise Floor f <sub>OFFSET</sub> ≥10MHz	NF		-157		dBc/Hz	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns
			-152.5		dBc/Hz	F <sub>IN</sub> =625MHz Slew Rate≥3V/ns

## Table 8. LVPECL Outputs Characteristics

Test Condition:  $-40^{\circ}C \le T_A \le 85^{\circ}C$ ,  $3.15V \le V_{DD} \le 3.45V$ ,  $2.375V \le V_{DDOX} \le 2.625$  or  $3.135V \le V_{DDOX} \le 3.45$ , CLK driven differentially, input slew rate  $\ge 3V/ns$ .

Parameters Sym	Symbol		Value		Unit	Notes
rarameters	Symbol	Min.	Typ.	Max.	Umt	Inotes

TEL:0086-0769-88010888

https://www.dptel.com/

m/ Songshan Lake, Dongguan, Guangdong

00





Parameters	Symbol	Value			Unit	Notes
QAn/nQAn,QBn/nQ	QBn					
		1000	1200		MHz	Full $V_{OD}$ Swing , $V_{OD} \ge$ 600mV, $R_L = 100\Omega$ differential, $V_{DDOX}=3.3V$ , $R_T=160\Omega$ to GND
Maximum Output	F <sub>out-</sub>	750	1000		MHz	
Frequency	MAX	1500	2200		MHz	$\begin{array}{l} \mbox{Reduced } V_{OD} \mbox{ Swing },  V_{OD} \\ \geqslant 400 mV,  R_L = 100 \Omega \\ \mbox{differential, } V_{DDOX} = 3.3V, \\  R_T = 160 \Omega \mbox{ to } GND \end{array}$
		1500	2200		MHz	Reduced $V_{OD}$ Swing , $V_{OD}$ $\geq 400 \text{mV}$ , $R_L = 100 \Omega$ differential, $V_{DDOX}=2.5 \text{V}$ , $R_T=91 \Omega$ to GND
Output Voltage Swing	V <sub>OD</sub>	600	830	1000	mV	
Output High Voltage	V <sub>OH</sub>	V <sub>DDOX</sub> - 1.2	V <sub>DDOX</sub> - 0.9	V <sub>DDOX</sub> - 0.7	V	$T_A = 25^{\circ}C, DC$ Measurement, $R_T = 50\Omega$ to
Output Low Voltage	V <sub>OL</sub>	V <sub>DDOX</sub> - 2.0	V <sub>DDOX</sub> - 1.75	V <sub>DDOX</sub> - 1.5	v	V <sub>DDO</sub> - 2V
Output Duty Cycle	Duty Cycle	45	50	55	%	XON
Output Rise Time, 20% to 80%	t <sub>Rise</sub>		250	350	ps	$R_T = 160\Omega$ to GND, uniform transmission line up to 10
Output Fall Time, 80% to 20%	t <sub>Fall</sub>		180	300	ps	inches with 50 $\Omega$ characteristic impedance, R <sub>L</sub> = 100 $\Omega$ differential, C <sub>L</sub> $\leq$ 5pF
Propagation Delay	t <sub>Delay</sub>	180	360	540	ps	$R_T = 160 \Omega$ to GND, $R_L = 50\Omega$ differential, $C_L \le 5pF$
Output Skew	t <sub>Skew</sub>		30	50	ps	Skew specified between any two CLKouts with the same buffer type. Load conditions
Part-to-part Output Skew	t <sub>PDP</sub>		80	120	ps	per output type are the same as propagation delay specifications.
			55		fs	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns 1MHz to 20MHz
			35		fs	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns 1MHz to 20MHz
Additive RMS Jitter	tı		25		fs	F <sub>IN</sub> =625MHz Slew Rate≥3V/ns 1MHz to 20MHz
			60	98	fs	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns 10kHHz to 20MHz
			30	78	fs	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns 10kHHz to

TEL:0086-0769-88010888

https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong

.





Parameters	Symbol	Value	Unit	Notes
				20MHz
		-161	dBc/ Hz	F <sub>IN</sub> =100MHz Slew Rate≥3V/ns
Noise Floor f <sub>OFFSET</sub> ≥10MHz	NF	-159	dBc/ Hz	F <sub>IN</sub> =156.25MHz Slew Rate≥3V/ns
		-154	dBc/ Hz	F <sub>IN</sub> =625MHz Slew Rate≥3V/ns

### Table 9. HCSL Outputs Characteristics

 $\label{eq:test} \begin{array}{l} \text{Test Condition: -40°C} \leq T_A \leq 85°C, 3.15V \leq V_{DD} \leq 3.45V, 2.375V \leq V_{DDOX} \leq 2.625 \text{ or } 3.135V \leq V_{DDOX} \leq 3.45v, \\ \text{CLK driven differentially, input slew rate} \geq 3V/\text{ns.} \end{array}$ 

Damara 4	C h = 1		Value		T	Natar
Parameters	Symbol Min. Typ. Max. Unit		Unit	Notes		
QAn/nQAn,QBn/nQH	Bn					
Output Frequency Range	F <sub>OUT</sub>	0		400	MHz	
Absolute Crossing Voltage	V <sub>CROSS</sub>	160	350	460	mV	$R_L = 50\Omega$ to GND, $C_L \le 5pF$
Total Variation of V <sub>CROSS</sub>	$\Delta V_{\text{CROSS}}$			140	mV	
Output High Voltage	$V_{\text{OH}}$	520	750	920	mV	$T_A = 25^{\circ}C$ , DC Measurement, $R_T$
Output Low Voltage	$V_{OL}$	-150	0.5	150	mV	$= 50\Omega$ to GND
Output Duty Cycle	Duty Cycle	45	50	55	%	53
Output Rise/Fall Time, 20% to 80%	t <sub>Rise</sub> /t <sub>Fall</sub>		300	500	ps	
Propagation Delay	t <sub>Delay</sub>	295	590	885	ps	$R_T$ = 50 $\Omega$ to GND, $C_L \leqslant 5 p F$
Output Skew	t <sub>Skew</sub>		30	50	ps	Skew specified between any two CLKouts with the same buffer
Part-to-part Output Skew	t <sub>PDP</sub>		80	120	ps	type. Load conditions per output type are the same as propagation delay specifications.
$\sim$			0.03	0.15	ps	PCIe Gen 3, PLL BW = 2-5MHz, CDR = 10MHz, $F_{IN}$ =100MHz Slew Rate $\geq 0.6V/ns$
	tj_pCle		0.03	0.05	ps	PCIe Gen 4, PLL BW = 2-5MHz, CDR = 10MHz, $F_{IN}$ =100MHz Slew Rate $\geq$ 1.8V/ns
Additive RMS Jitter			77		fs	$V_{DDO} = 3.3V, R_T = 50\Omega \text{ to GND}$ F <sub>IN</sub> =100MHz Slew Rate $\geq 3V/ns$ 1MHz to 20MHz
	tJ		86		fs	$V_{DDO} = 3.3V, R_T = 50\Omega \text{ to GND}$ F <sub>IN</sub> =156.25Hz Slew Rate $\geq 3V/ns$ 1MHz to 20MHz
Noise Floor f <sub>OFFSET</sub> ≥10MHz	NF		-161		dBc/ Hz	$\label{eq:V_DDO} \begin{split} V_{\text{DDO}} &= 3.3 V,  R_T = 50 \Omega \text{ to GND} \\ F_{\text{IN}} &= 100 MHz \end{split}$

TEL:0086-0769-88010888

https://www.dptel.com/





Parameters	Symbol	Value		Unit	Notes
					Slew Rate $\geq 3V/ns$
		-156		dBc/ Hz	$\label{eq:DDD} \begin{split} V_{DDO} &= 3.3 V,  R_T = 50 \Omega \text{ to GND} \\ F_{IN} &= 156.25 Hz \\ Slew  Rate &\geq 3 V/ns \end{split}$

### Table 10. LVCMOS Outputs Characteristics

Test Condition: -40°C $\leq$ T<sub>A</sub> $\leq$ 85°C,3.15V $\leq$ V<sub>DD</sub> $\leq$ 3.45V, 2.375V $\leq$ V<sub>DDOX</sub> $\leq$ 2.625 or 3.135V $\leq$ V<sub>DDOX</sub> $\leq$ 3.45, CLK driven differentially, input slew rate  $\geq$  3V/ns.

Description	C h . h		Value		<b>T</b> T . •4	Nadar	
Parameters	Symbol	Min.	Тур.	Max.	Unit	Notes	
Output High Voltage	V <sub>OH</sub>	V <sub>DDOX</sub> - 0.1			V	1mA Load	
Output Low Voltage	Vol			0.1	V	This I Doub	
Output Wigh Current	I <sub>OH</sub>		28		mA	V <sub>DDOX</sub> =3.3V	
Output High Current	IOH		20		mA	V <sub>DDOX</sub> =2.5V	
Output Loui Cumont	т		28		mA	V <sub>DDOX</sub> =3.3V	
Output Low Current	I <sub>OL</sub>		20		mA	V <sub>DDOX</sub> =2.5V	
Output Frequency Range(	Fout	0		300	MHz	$CL \leq 5pF$	
Output Duty Cycle	Duty Cycle	45	50	55	%	50% input clock duty cycle	
Output Rise Time, 20% to 80%	t <sub>Rise</sub>	Ś	225	500	ps	250MHz, uniform transmission line up to 10 inches with $50\Omega$ characteristic impedance,	
Output Fall Time, 20% to 80%	t <sub>Fall</sub>		225	400	ps	$R_L = 50\Omega$ to GND, $C_L \leq 5pF$	
Promocotion Dalay		900	1475	2300	ps	$V_{DDOX}$ =3.3V, CL $\leq$ 5pF	
Propagation Delay	t <sub>Delay</sub>	1000	1550	2700	ps	$V_{DDOX}$ =2.5V, CL $\leq$ 5pF	
Additive RMS Jitter, BW = 1MHz to 20MHz	tJ		132		fs	$V_{DDO} = 3.3V$ $C_L \leqslant 5 pF F_{IN} = 100 MHz$	
Noise Floor, f <sub>OFFSET</sub> ≥ 10MHz			-158		dBc/ Hz	Slew Rate $\geq$ 3V/ns	
Output Enable/Disable Time	$t_{\rm EN}/t_{\rm DIS}$			3	Cycle	$C_L \leqslant 5 pF$	

https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong

# INS6310A

#### FUNCTION DESCRIPTION 5

## 5.1 Control Signals

INS6310A has three groups of control signals:

- Input Selection  $\geq$
- $\geq$ **Output Type Selection**
- $\triangleright$ **Reference Output Enable**

Clock input selection is controlled using the SEL0 and SEL1 pins as shown in Table 11. Refer to Driving the Clock Inputs for clock input requirements. When CLK0 or CLK1 is selected, the crystal circuit is powered down. When Xin is selected, the crystal oscillator will start-up and its clock will be distributed to all outputs. Refer to Crystal Interface for more information. Alternatively, Xin may be driven by a singleended clock, up to 250MHz, instead of a crystal.

SEL[1]	<b>SEL[0]</b>	Selected Input	
0	0	CLK0/nCLK0	
0	1	CLK1/nCLK1	
1	Х	X <sub>IN</sub> /X <sub>OUT</sub>	Ġ

The differential output buffer type for Bank A and Bank B outputs can be separately configured using the OTYPEA[1:0] and OTYPEB[1:0] inputs, respectively, as shown in table 12. For applications where all differential outputs are not needed, any unused output pin should be left floating with a minimum copper length to minimize capacitance and potential coupling and reduce power consumption. If an entire output bank will not be used, it is recommended to disable (Hi-Z) the bank to reduce power. Refer to Termination and Use of Clock Drivers for more information on output interface and termination techniques.

Table 12.	Output Type Selection
-----------	-----------------------

OTYPEx[1]	OTYPEx[0]	Output Type (BankA or B)
0	0	LVPECL
0	1	LVDS
1	0	HCSL
1	1	Hi-Z

Notes: OTYPEx represent OTYPEA and OTYPEB

The reference output (REFOUT) provides a LVCMOS copy of the selected input clock. The LVCMOS output high level is referenced to the V<sub>DDO</sub> voltage. REFOUT can be enabled or disabled using the enable input pin, REFOUT\_OE, as shown in Table 13.

Table 13. Reference Output Enable			
<b>REFOUT _OE</b> Reference Output State			
0	Hi-Z		
1	Enabled		

TEL:0086-0769-88010888

https://www.dptel.com/



## 5.2 Input Clocks

**CLK/nCLK differential inputs:** The INS6310A has two differential inputs (CLK0/nCLK0 and CLK1/nCLK1) that can accept AC or DC coupled 3.3V/2.5V LVPECL, LVDS, CML, SSTL and other differential and single-ended signals that meet the input requirements specified in ELECTRICAL CHARACTERISTICS. The device can accept a wide range of signals due to its wide input common mode voltage range (V<sub>CM</sub>) and input voltage swing (V<sub>ID</sub>). It is recommended that the inputs have a high slew rate of 3 V/ns (differential) or higher in case to degrade the noise floor and jitter. For this reason, a differential input signal is recommended over single-ended because it typically provides higher slew rate and common-mode noise rejection.

**CLK/nCLK single-ended inputs:** It is possible to drive it with a single-ended clock. For large single-ended input signals, such as 3.3V or 2.5V LVCMOS, a 50 $\Omega$  load resistor should be placed near the input for signal attenuation to prevent input overdrive as well as for line termination to minimize reflections. The CLK input has an internal bias voltage of about 1.4V, so the input can be AC coupled as shown in Figure3. The output impedance of the LVCMOS driver plus R1 should be close to 50  $\Omega$  to match the characteristic impedance of the transmission line and load termination.

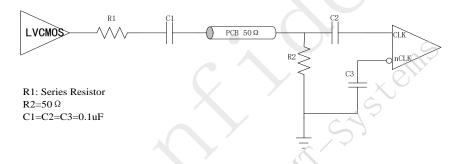
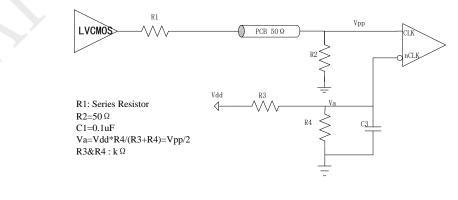


Figure 3. Single-Ended LVCMOS input, AC Coupling

A single-ended clock may also be DC coupled to CLKx as shown in Figure 4. A 50 $\Omega$  load resistor should be placed near the CLKx input for signal attenuation and line termination. Because half of the singleended swing of the driver (V<sub>0,PP</sub>/2) drives CLKx, nCLKx should be externally biased to the midpoint voltage of the attenuated input swing ((V<sub>0,PP</sub>/2)×0.5). The external bias voltage should be within the specified input common voltage (V<sub>CM</sub>) range. This can be achieved using external biasing resistors in the k $\Omega$  range (R3 and R4) or another low-noise voltage reference. This will ensure the input swing crosses the threshold voltage at a point where the input slew rate is the highest.





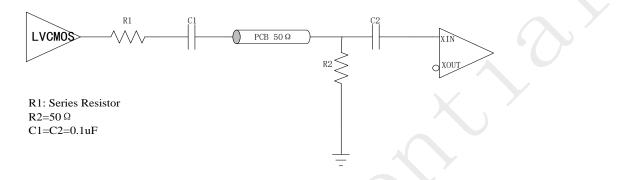
TEL:0086-0769-88010888

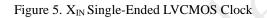
https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong



 $X_{IN}/X_{0UT}$ : If the crystal oscillator circuit is not used, it is possible to drive the Xin input with a singleended external clock as shown in Figure 5. The input clock should be AC coupled to the Xin pin, which has an internally generated input bias voltage, and the Xout pin should be left floating. While Xin provides an alternative input to multiplex an external clock, it is recommended to use either differential input (CLKx) since it offers higher operating frequency, better common mode, improved power supply noise rejection and greater performance over supply voltage and temperature variations.





The INS6310A has an integrated crystal oscillator circuit that supports a fundamental mode, AT-cut crystal. The crystal interface is shown in Figure 6, while CL is specified for the crystal and  $C_{Shunt}$  is the sum of  $C_{IN}$  and PCB  $C_{STRAY}$ .

As shown in Figure 6, an external resistor,  $R_{LIMIT}$ , can be used to limit the crystal drive level if necessary. If the power dissipated in the selected crystal is higher than the drive level specified for the crystal with  $R_{LIMIT}$  shorted, then a larger resistor value is mandatory to avoid overdriving the crystal. However, if the power dissipated in the crystal is less than the drive level with  $R_{LIMIT}$  shorted, then a zero value for  $R_{LIMIT}$  can be used. As a starting point, a suggested value for RLIM is 1.5k $\Omega$ .

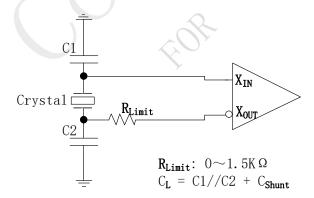


Figure 6.  $X_{IN}/X_{OUT}$  Crystal Interface

## **5.3 CLOCK OUTPUTS**

INS6310A has two banks of 5 differential outputs and one LVCMOS output which can be independently supplied with 3.3V or 2.5V.

. TEL:0086-0769-88010888 http

https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong





Table 14. Clock Outputs			
Bank	Outputs		
Bank A	QA0, QA1, QA2, QA3, QA4		
Bank B	QB0, QB1, QB2, QB3, QB4		
REFOUT	REFOUT		

Table 2 following will be the state of the outputs.

SEL[1]	Input Clock	Output State
	CLKx=Open nCLKx=Open	Logic Low
LecieLevy	CLK= Logic High nCLK= Logic Low	Logic High
Logic Low	CLK= Logic Low nCLK= Logic High	Logic Low
	CLK and nCLK short	Logic Low
Logic High	X <sub>IN</sub> = Logic High	Logic Low
	X <sub>IN</sub> = Logic Low	Logic High

#### Notes

• Unused outputs should be left floating with a minimum copper length to minimize capacitance. In this way, this output will consume minimal output current because it has no load.

### 5. 3. 1 Termination and Use of Clock Drivers

When terminating clock drivers keep in mind these guidelines for optimum phase noise and jitter performance:

- Transmission line theory should be followed for good impedance matching to prevent reflections.
- Clock drivers should be presented with the proper loads.
  - > LVDS outputs are current drivers and require a closed current loop.
  - > HCSL drivers are switched current outputs and require a DC path to ground via  $50\Omega$  termination.
  - > LVPECL outputs are open emitter and require a DC path to ground.
- Receivers should be presented with a signal biased to their specified DC bias level (common mode voltage) for proper operation. Some receivers have self-biasing inputs that automatically bias to the proper voltage level; in this case, the signal should normally be AC coupled.

It is possible to drive a non-LVPECL or non-LVDS receiver with a LVDS or LVPECL driver as long as the above guidelines are followed. Check the datasheet of the receiver or input being driven to determine the best termination and coupling method to be sure the receiver is biased at the optimum DC voltage (common mode voltage)

### **Termination for LVDS Driver**

For DC coupled operation, terminate with  $100\Omega$  as close as possible to the LVDS receiver. For AC coupled operation by adding DC blocking capacitors, the load termination resistor and AC coupling capacitors should be placed as close as possible to the receiver inputs to minimize stub length, as shown in Figure 7

TEL:0086-0769-88010888 https://www.dptel.com/ Songshan Lake, Dongguan, Guangdong





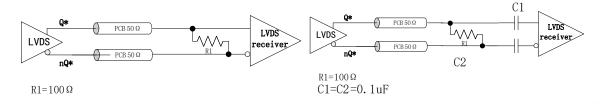


Figure 7. LVDS DC&AC Coupling

#### **Termination for LVPECL Driver**

For DC coupled operation of an LVPECL driver, terminate with 50 $\Omega$  to V<sub>DDO</sub> - 2V. Alternatively terminate with a Thevenin equivalent circuit for V<sub>DDO</sub> (output driver supply voltage) = 3.3V and 2.5V. In the Thevenin equivalent circuit, the resistor dividers set the output termination voltage (V<sub>TT</sub>) to V<sub>DDO</sub> - 2V. as shown in Figure 8

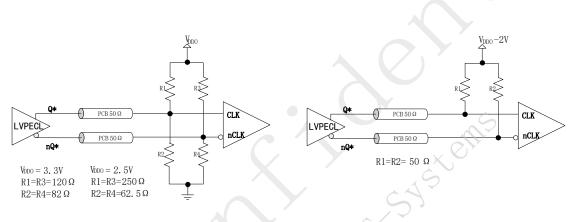
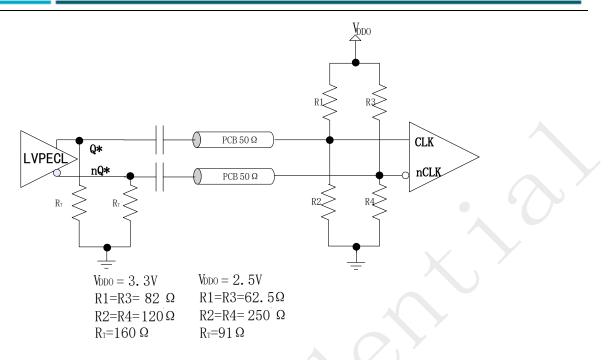
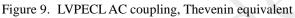


Figure 8. LVPECL DC Coupling

When AC coupling an LVPECL signal use  $160\Omega$  emitter resistors (or  $91\Omega$  for  $V_{DDO} = 2.5V$ ) close to the LVPECL driver to provide a DC path to ground as shown in Figure 9. For proper receiver operation, the signal should be biased to the DC bias level (common mode voltage) specified by the receiver. The typical DC bias voltage (common mode voltage) for LVPECL receivers is 2.0V. Alternatively, a Thevenin equivalent circuit forms a valid termination as shown in Figure 9 for  $V_{DDO} = 3.3V$  and 2.5V. This Thevenin circuit is different from the DC coupled example in Figure 8, since the voltage divider is setting the receiver input common mode voltage.

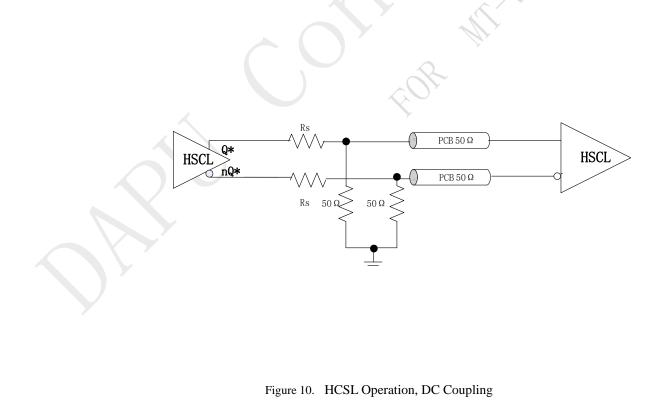






### **Termination for HSCL Driver**

For DC coupled operation of an HCSL driver, terminate with  $50\Omega$  to ground near the driver output as shown in Figure 10. Series resistors,  $R_s$ , may be used to limit overshoot due to the fast transient current. Because HCSL drivers require a DC path to ground, AC coupling is not allowed between the output drivers and the  $50\Omega$  termination resistors.







## 5.4 Power Supply

The INS6310A operates from a 3.3V core supply and 3 independent 3.3V/2.5V output supplies.

VDD is INS6310A core supply voltage support 3.3V.

VDDOA, VDDOB and VDDOC are power supply for Bank A, B, C output buffers respectively. They can operate from 3.3V or 2.5V.

#### Notes

- $V_{DDO}$  should be less than or equal to  $V_{DD}$  ( $V_{DDO} \leqslant V_{DD}$ )
- .1uF or 0.01uF bypass capacitors should be placed very close to each supply pin
- 1uF to 10uF Decoupling capacitors should be placed nearby

Version: <u>1.2</u>

TEL:0086-0769-88010888 https://www.dptel.com/

otel.com/ Songshan Lake, Dongguan, Guangdong





## 6 ENVIRONMENT

Parameters	Value	Unit Notes		
ESD Level	±2000V	v	HBM, Refer to ANSI/ESDA/JEDEC JS-001-2010	
	±800V	V	CDM, Refer to JEDEC specification JESD22-C101	
	±000 v	v	CDM, Refer to JEDEC specification JESD22-C101	

Table 16. ENVIRONMENT CONDITIONS

\* HBM: Human body model

CDM: Charged-device model

# 7 PACKAGE OUTLINE

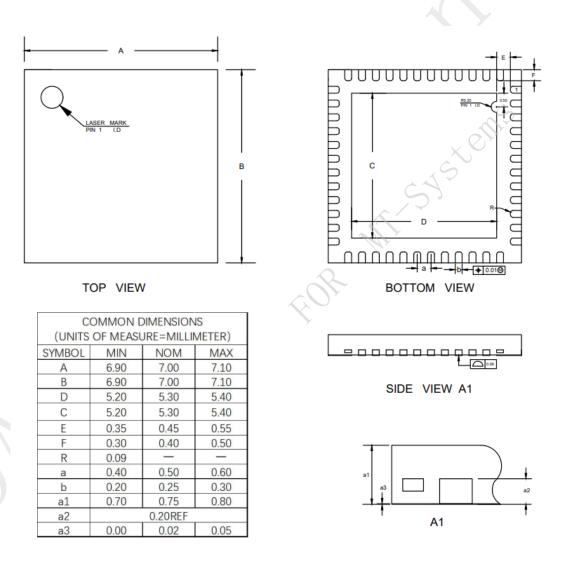


Figure 11.Package Outline Diagram

TEL:0086-0769-88010888

https://www.dptel.com/

Songshan Lake, Dongguan, Guangdong